

Notice of References Cited	Application/Control No. 10/762,480	Applicant(s)/Patent Under Reexamination OTAKE ET AL.	
	Examiner Rodney Amadiz	Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0166829	08-2004	Nakae et al.	455/403
*	B	US-2005/0188001	08-2005	Shiono et al.	709/200
	C	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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